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Key indicators

Single-crystal X-ray study T = 293 K Mean σ (C–C) = 0.002 Å R factor = 0.041 wR factor = 0.112 Data-to-parameter ratio = 15.3

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

1-(4-Chlorophenyl)-3-(1*H*-imidazol-1-yl)propan-1-one

The molecule of the title compound, $C_{12}H_{11}ClN_2O$, is nonplanar, the benzene and imidazole rings making a dihedral angle of 72.5 (1)°. Molecules are linked into a threedimensional framework by weak intermolecular $C-H\cdots O$ and $C-H\cdots N$ hydrogen bonds. Received 7 July 2005 Accepted 19 July 2005 Online 23 July 2005

Comment

A molecular view of the title compound, (I), is shown in Fig. 1. The bond lengths and angles are within normal ranges (Allen *et al.*, 1987) and compare well with those reported in the related compound, (II) (Wan *et al.*, 2005). In contrast to the planar conformation of (II), compound (I) is non-planar, with the substituted benzene ring and the imidazole ring making a dihedral angle of 72.5 (1)°.



In the crystal structure, molecules are linked into a threedimensional framework by weak intermolecular $C-H\cdots O$ and $C-H\cdots N$ hydrogen bonds (Fig. 2 and Table 1).





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Experimental

To a solution of 1-(4-chlorophenyl)-3-(dimethylamino)propan-1-one (10.6 g, 0.05 mol) in water (25 ml) was added imidazole (4.4 g, 0.06 mol). The mixture was heated under reflux for 5 h, yielding a copious precipitate. Colorless single crystals suitable for X-ray diffraction study were obtained by slow evaporation of a dichloromethane-cyclohexane (1:2, ν/ν) solution over a period of 5 d.

 $D_x = 1.375 \text{ Mg m}^{-3}$ Mo K\alpha radiation Cell parameters from 2278 reflections $\theta = 2.9-25.9^{\circ}$ $\mu = 0.32 \text{ mm}^{-1}$ T = 293 (2) K Plate, colorless $0.49 \times 0.26 \times 0.06 \text{ mm}$

Crystal data

C ₁₂ H ₁₁ ClN ₂ O
$M_r = 234.68$
Monoclinic, $P2_1/n$
a = 10.4902 (9) Å
b = 8.1611 (7) Å
c = 13.8691 (12) Å
$\beta = 107.252 \ (1)^{\circ}$
$V = 1133.94 (17) \text{ Å}^3$
Z = 4

Data collection

Siemens SMART 1000 CCD area-	2218 independent reflections
detector diffractometer	1860 reflections with $I > 2\sigma(I)$
ω scans	$R_{\rm int} = 0.017$
Absorption correction: multi-scan	$\theta_{\rm max} = 26.0^{\circ}$
(SADABS; Sheldrick, 1996)	$h = -12 \rightarrow 12$
$T_{\min} = 0.861, \ T_{\max} = 0.981$	$k = -10 \rightarrow 9$
6176 measured reflections	$l = -17 \rightarrow 13$

Refinement

Refinement on F^2	$w = 1/[\sigma^2(F_0^2) + (0.0533P)^2$
$R[F^2 > 2\sigma(F^2)] = 0.041$	+ 0.2452 <i>P</i>]
$wR(F^2) = 0.112$	where $P = (F_0^2 + 2F_c^2)/3$
S = 1.05	$(\Delta/\sigma)_{\rm max} < 0.001$
2218 reflections	$\Delta \rho_{\rm max} = 0.18 \text{ e } \text{\AA}^{-3}$
145 parameters	$\Delta \rho_{\rm min} = -0.19 \text{ e } \text{\AA}^{-3}$
H-atom parameters constrained	

Table 1

Hydrogen-bond geometry (Å, °).	
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			$D=11\cdots A$
C4-H4···O1 ⁱ 0.9	03 2.5	1 3.353 ((2) 151
$C8-H8A\cdots N2^{ii}$ 0.9	2.5	7 3.499 ((2) 160

Symmetry codes: (i) $x - \frac{1}{2}, -y + \frac{3}{2}, z - \frac{1}{2}$, (ii) $-x + \frac{3}{2}, y + \frac{1}{2}, -z + \frac{1}{2}$.

All H atoms were located in difference Fourier maps but they were treated as riding on their parent atoms $[C-H = 0.93 \text{ and } 0.97 \text{ Å}, \text{ and } U_{iso}(H) = 1.2U_{eq}(C)].$

Data collection: *SMART* (Siemens, 1996); cell refinement: *SAINT* (Siemens, 1996); data reduction: *SAINT*; program(s) used to solve structure: *SHELXTL* (Sheldrick, 1997); program(s) used to refine





structure: *SHELXTL*; molecular graphics: *SHELXTL*; software used to prepare material for publication: *SHELXTL*, *PARST* (Nardelli, 1995) and *PLATON* (Spek, 2003).

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